

AO4488

N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO4488/L uses advanced trench technology to provide excellent $R_{\text{DS}(\text{ON})}$ with low gate charge.

This device is ESD protected and it is suitable for use as a load switch or in PWM applications. AO4488 and AO4488L are electrically identical.

- -RoHS Compliant
- -AO4488L is Halogen Free

Features

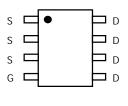
 $V_{DS}(V) = 30V$

 $I_{D} = 20A$

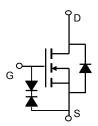
 $(V_{GS} = 10V)$

 $R_{DS(ON)}$ < 4.6m Ω (V_{GS} = 10V)

 $R_{DS(ON)}$ < 6.4m Ω (V_{GS} = 4.5V)







Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	10 Sec	Steady State	Units		
Drain-Source Voltage		V_{DS}	30		V		
Gate-Source Voltage		V_{GS}	±20		V		
Continuous Drain Current ^A	T _A =25°C		20	15			
	T _A =70°C	I _D	17	12	۸		
Pulsed Drain Current ^B		I _{DM}	80		А		
Avalanche Current ^G		I _{AR}	50				
Repetitive avalanche energy L=0.3mH ^G		E _{AR}	375		mJ		
Power Dissipation ^A	T _A =25°C	D	3.1	1.7	W		
	T _A =70°C	P _D	2.0	1.1	VV		
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150		°C		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s Steady State		31	40	°C/W			
Maximum Junction-to-Ambient A			59	75	°C/W			
Maximum Junction-to-Lead ^C	Steady State	$R_{ hetaJL}$	16	24	°C/W			

Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 30V, V _{GS} = 0V			1	
		T _J = 55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	$V_{DS} = 0V$, $V_{GS} = \pm 16V$			±10	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS} I_{D} = 250 \mu A$	1.0	1.7	3	V
$I_{D(ON)}$	On state drain current	$V_{GS} = 10V, V_{DS} = 5V$	80			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 20A		3.8	4.6	
		T _J =125°C		5.3	6.5	mΩ
		$V_{GS} = 4.5V, I_D = 18A$		5.2	6.4	
g FS	Forward Transconductance	$V_{DS} = 5V, I_{D} = 20A$		72		S
V_{SD}	Diode Forward Voltage	$I_S = 1A, V_{GS} = 0V$		0.69	1	V
Is	Maximum Body-Diode Continuous Curr			3	Α	
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			5450	6800	pF
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		760		pF
C _{rss}	Reverse Transfer Capacitance			540		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1	1.5	Ω
SWITCHI	NG PARAMETERS					
Q _g (10V)	Total Gate Charge			84	112	nC
Q _g (4.5V)	Total Gate Charge	V -10V V -15V I -20A		42	56	nC
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =15V, I_{D} =20A		12		nC
Q_{gd}	Gate Drain Charge	1		21		nC
t _{D(on)}	Turn-On DelayTime			13		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} =0.75 Ω ,		9.8		ns
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		49		ns
t _f	Turn-Off Fall Time	1		16		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μs		42	56	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μs		31		nC

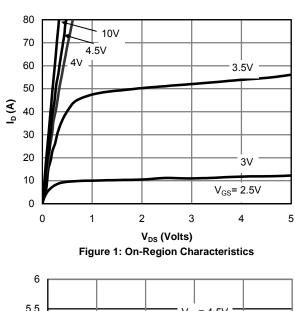
A: The value of R $_{\text{BJA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_{\text{A}}$ = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t $_{\text{A}}$ = 10s thermal resistance rating.

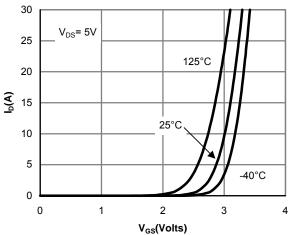
- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.
- D. The static characteristics in Figures 1 to 6 are obtained using < 300 μs pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating.
- F. The current rating is based on the $t \leqslant 10\mbox{s}$ thermal resistance rating.
- G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j =25C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





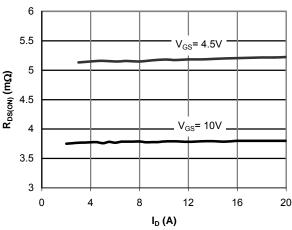


Figure 2: Transfer Characteristics

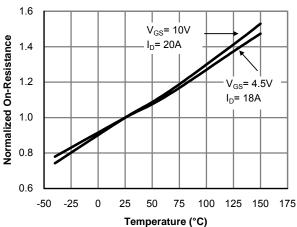
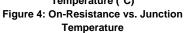
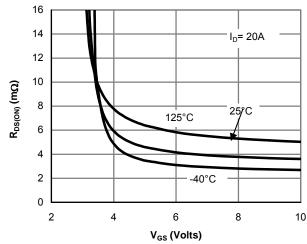


Figure 3: On-Resistance vs. Drain Current and Gate Voltage





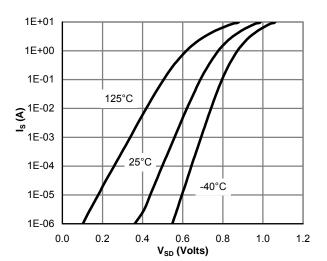
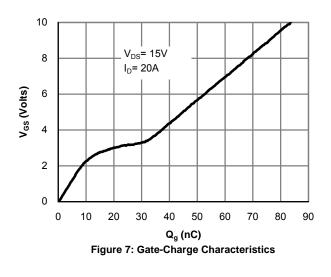


Figure 5: On-Resistance vs. Gate-Source Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



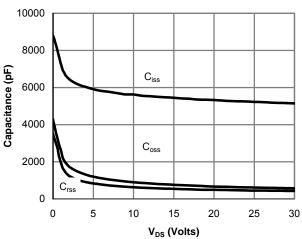


Figure 8: Capacitance Characteristics

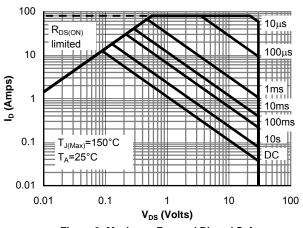


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

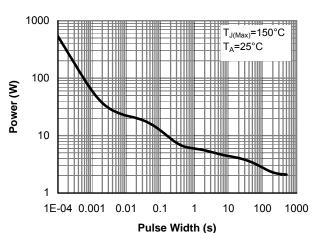


Figure 10: Single Pulse Power Rating Junctionto-Ambient (Note E)

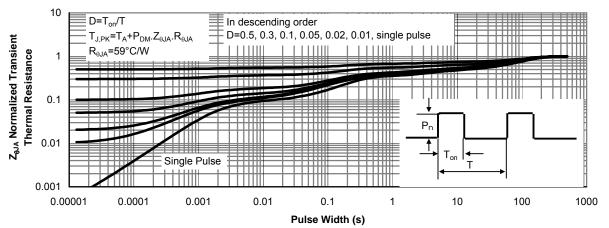


Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

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